



From the Editor

2016 *Microscopy Today* Innovation Awards

Congratulations to the winners of the seventh annual *Microscopy Today* Innovation Awards competition. These awards honor innovative microscopy-related products and methods that appeared in the previous year.

Our team of judges, led by Tom Kelly, looked for innovations that will make new scientific investigations possible. The ten winning innovations were selected on the basis of their importance and usefulness to the microscopy community. The entries most likely to win are those that provide better, faster, or entirely new methods of analysis using some type of microscope or microanalytical instrument.

The 2016 *Microscopy Today* Innovation Award winners are:

Brookhaven and Argonne National Laboratories for a new hard x-ray scanning microscope
Excelitas Technologies for the X-Cite® TURBO with LaserLED Hybrid Drive™ illuminator
Leica Microsystems for the TCS SP8 DLS Confocal Microscope with light sheet illumination
Nanojehm, Inc. for the SEM Aura Work Station with image sharpening software
Oak Ridge National Laboratory for G-mode microscopy and spectroscopy in SPM systems
Scientifica Ltd for SciScan software that automates laser scanning microscopes
Technical Manufacturing Corporation for the Everstill™ K-400 vibration cancellation system
Vision Engineering, Inc. for the Lynx EVO eyepiece-less stereo microscope
Yale University for the speckle-free semiconductor laser enabling high-speed imaging
Carl Zeiss Microscopy for the Stemi 305 with Labscope Wi-Fi networking system

Descriptions of the above innovations are given in an article within this issue. This article also lists the developers of these methods.

Details of the nomination process for the next competition will be posted on the *Microscopy Today* website (www.microscopy-today.com) by January 1, 2017. Nomination applications will be accepted through March 21, 2017.

Charles Lyman
Editor-in-Chief

Publication Objective: to provide information of interest to microscopists.

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